

<b>Notice of References Cited</b>	Application/Control No. 10/585,531		Applicant(s)/Patent Under Reexamination NGUYEN ET AL.	
	Examiner NATHAN H. EMPIE		Art Unit 1712	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,299,734	11-1981	Fujitani et al.	502/304
*	B	US-5,217,938	06-1993	Reinalda et al.	502/325
*	C	US-5,437,832	08-1995	Imamura et al.	419/2
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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	M	US-			

#### FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
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#### NON-PATENT DOCUMENTS

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